

# Search Notes



Application/Control No.

10/532,226

Examiner

Tran N. Nguyen

Applicant(s)/Patent under  
Reexamination

JUNG ET AL.

Art Unit

2834

## SEARCHED

Class	Subclass	Date	Examiner
310	162 166 168 211	7/4/06	JAN
310	212 216 261	7/5/06	JAN
update	all above	1/18/07	JAN
update	all above	6/8/07	JAN

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
310	all of above	6/8/07	JAN

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
Interference Search	6/8/07	JAN